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Quasi-In Situ 4D-STEM Mapping of Exsolution Driven Parent Matrix Restructuring in $\text{Sr}_2\text{FeMoO}_{6-\delta}$

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ABSTRACT

The in situ exsolution of catalytic particles upon reduction makes double-perovskites promising candidates for next-generation solid oxide cells (SOCs). While recent in situ S/TEM studies have visualized this process, these investigations have primarily focused on isolated particles rather than realistic electrode architectures and the effect of exsolution on the surrounding host matrix remains largely unexplored. Herein, a quasi-in situ S/TEM approach is presented to investigate the impact of exsolution on a realistic $\text{Sr}_2\text{FeMoO}_{6-\delta}$ (SFM) electrode by decoupling the influence of electron-beam-induced artifacts. By extracting a lamella from a bulk SOC using a plasma-FIB and performing identical-location characterization utilizing EDS and 4D-STEM before and after reduction captures both the chemical segregation and intrinsic structural transformations within the electrode grains. Utilizing iDPC and radial Fourier analysis (RFA), this approach reveals that surface exsolution is coupled with substantial crystallographic reorganization within the SFM matrix, evidenced by distinct domain shrinkage and localized phase gradients along grain facets. The interconnected bulk electrode geometry promotes higher exsolution density compared to isolated powder particles, underscoring the necessity of studying realistic architectures. By linking surface exsolution to matrix modification in a realistic bulk electrode geometry, this quasi-in situ methodology provides a vital insights into the exsolution process.

1 | Introduction

SOCs are high-temperature ($\sim 600^\circ\text{C}$ – 1000°C) electrochemical energy conversion devices that are operated as either solid oxide fuel cells (SOFCs) or solid oxide electrolysis cells (SOECs) [1–3]. SOC enable efficient power generation and low-carbon fuel production, and are posed to play a pivotal role in advancing Power-to-X (P2X) pathways and supporting global decarbonization targets [4–7]. Consequently, the long-term performance, and reliability of SOC are crucial for their widespread practical deployment. In SOC, the electrochemical reactions are strongly influenced by the microstructure and catalytic activity of the

electrode, and the overall performance of the SOC is primarily dependent on the electrode performance [8–10]. While traditional industrial SOC rely on Ni-yttria-stabilized zirconia (Ni-YSZ) cermet [11–14], these electrodes suffer from several degradation phenomenon under operating conditions, such as Ni coarsening, carbon coking, redox instability, and sulfur poisoning, reducing the long-term electrochemical performance of the SOC [15–18].

To overcome these limitations, double-perovskite oxides ($\text{A}_2\text{BB}'\text{O}_6$ structure) have emerged as promising alternative electrode materials. They offer tunable electrochemical properties and demonstrate mixed ionic and electronic

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conductivity (MIEC) due to the presence of a high concentration of oxygen vacancies [19–21]. A particularly fascinating property of materials like $\text{Sr}_2\text{FeMoO}_{6-\delta}$ (SFM) is the in situ exsolution of catalytic transition metals (e.g., Fe) from the B/B' cationic sites to the bulk surface upon reduction [21, 22]. These exsolved metallic nanoparticles remain strongly anchored to the parent material surface, significantly enhancing the catalytically active surface area, and thereby improving electrochemical activity and the overall cell efficiency [24–26]. Furthermore, these strong anchoring suppresses particle coarsening and agglomeration, limits carbon coking, thus addressing the key degradation phenomenon observed for conventional SOC electrodes [27]. In our previous work with SFM-GDC electrodes, electrolyte-supported single cells exhibited current densities of -1.26 and -1.27 A cm^{-2} under steam and co-electrolysis conditions, respectively, outperforming conventional Ni-YSZ electrodes by $\sim 38\%$ and approaching Ni-GDC performance. Long-term stability was demonstrated over 500 h at -0.3 A cm^{-2} and 900°C under a 50% H_2O -50% H_2 atmosphere [22].

Previous studies elucidated the mechanisms governing B/B'-site cation exsolution in SFM and its doped variants by reducing isolated powder particles under in situ electron microscopy [22, 28]. While highly informative for visualizing the emergence of nanoparticles, these particle-based observations fail to capture the complex exsolution mechanisms occurring within interconnected, bulk electrode architectures. Consequently, the structural and crystallographic impact of exsolution on the surrounding parent matrix remains insufficiently resolved. Furthermore, while in situ TEM enables real-time imaging under controlled temperature, gas, and pressure, continuous electron irradiation at such extreme conditions can induce beam-induced artefacts that might complicate accurate interpretation of the material's intrinsic behavior [29–32].

To bridge this methodological gap, we utilized a quasi-in situ (off-beam) reduction approach on a bulk SOC lamella. Using a Xe^+ plasma-focused ion beam (PFIB), a lamella was extracted from a fully fabricated SOC comprising $\text{Sr}_2\text{FeMoO}_{6-\delta}$ (SFM) electrode, $\text{Ce}_{0.8}\text{Gd}_{0.2}\text{O}_{1.9}$ (GDC) barrier layer, and 8 mol% yttria-stabilized zirconia (8YSZ) electrolyte. By reducing the lamella off-beam in a microelectromechanical systems (MEMS) nanoreactor and performing identical-location analysis, we eliminate electron-beam-driven artifacts while preserving realistic bulk electrode geometry. We map the morphological and chemical changes associated with exsolutions using conventional S/TEM and energy-dispersive x-ray spectroscopy (EDS). Crucially, to understand the matrix transformations surrounding the Fe-exsolutions, we employed 4D-STEM mapping of the identical regions before and after reduction. This enabled integrated differential phase-contrast (iDPC) imaging and rapid crystallographic orientation mapping via radial Fourier analysis (RFA) [33–36]. Although PFIB preparation, MEMS gas-heating, and correlative imaging are individually established methodologies, the present work combines them to enable a capability that is not available in most exsolution studies, i.e. off-beam reduction of a SOC-derived bulk electrode lamella, followed by identical-location 4D-STEM mapping to quantify how surface exsolution couples to crystallographic reorganization of the surrounding matrix. This beam-decoupled, bulk-relevant approach complements particle-based quasi-in situ studies and provides a direct route to separate

intrinsic reduction effects from irradiation-driven artifacts. By coupling off-beam environmental reduction with 4D-STEM mapping, this workflow provides a direct link between surface catalytic exsolution with minimized beam-induced artifacts, and concurrent nanoscale crystallographic reorganization within the parent electrode grains.

2 | Results and Discussion

To evaluate the microstructural evolution of the bulk electrode, an electron-transparent cross-sectional lamella was extracted from a pristine symmetric cell (SFM/GDC/8YSZ/GDC/SFM) using a Xe^+ PFIB (Figure S1, Table S1). The lamella was then transferred to a gas-heating MEMS chip (DENSsolutions Climate) and secured with platinum deposition for ensuring mechanical stability. Crucially for this methodology, the chip was mounted in a specialized holder (Climate Infinity) that enables flexible tip orientation, allowing optimized geometries for different electron beam modes.

Specifically, for STEM mode operation a top-facing configuration was used (Figure 1a), positioning the lamella directly beneath the upper electron-transparent SiN_x window. This minimizes the effective gas path before the convergent probe reaches the specimen. This reduces the pre-sample electron-beam scattering and preserves the probe coherence, which is critical for achieving the high-order spatial resolution [37]. In contrast, for TEM imaging mode, a bottom-facing configuration is preferred (Figure 1b). In this geometry, the parallel beam interacts first with the specimen and subsequently traverses a shorter gas path after interaction. This limits the post-specimen electron-beam scattering and thereby maintains the image coherence and high-resolution information transfer to the microscope camera.

Following the assembly in the top-facing configuration, the electron transparency and structural integrity of the SOC lamella suspended over the SiN_x window were first verified by HAADF-STEM overview imaging (Figure 2a), confirming a continuous, electron-transparent region suitable for correlative pre- and post-reduction analysis. Higher-magnification HAADF-STEM images acquired from representative areas of the SFM electrode, sampled from both the periphery and the centre of the lamella, show a smooth and homogeneous surface without discernible nanoscale secondary features (Figure 2b,c). This appearance is consistent with the pristine, as-prepared state of SFM and agrees with observations from previous studies [22]. Elemental integrity was further assessed by EDS mapping of the region in Figure 2c, which shows a uniform distribution of Sr, Fe, Mo, and O across the electrode matrix (Figure 2d–g) without evidence of local segregation or milling-induced compositional artefacts. Together, these results confirm that Xe^+ -PFIB preparation preserved the surface morphology and bulk composition of the SFM matrix, providing a reliable baseline for attributing subsequent microstructural and crystallographic changes to the reduction treatment rather than preparation artefacts.

To induce exsolution, the lamella was subjected to off-beam reduction within the MEMS nanoreactor (4% H_2/Ar at 1 bar, 800°C for 30 min). Subsequent HAADF-STEM overview imaging of the exact SFM electrode region reveals pronounced surface

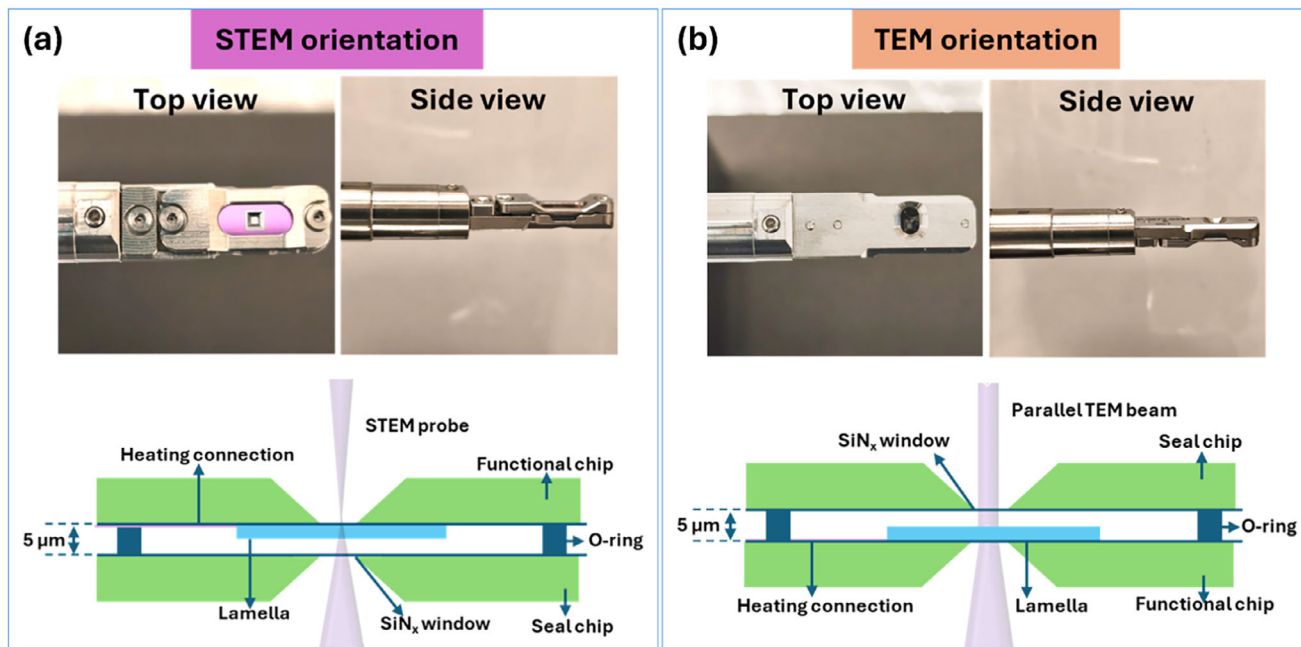


FIGURE 1 | Experimental configuration for quasi-in situ electron microscopy using a variable-orientation MEMS holder. (a) Top-facing configuration used for STEM mode. This arrangement positions the lamella adjacent to the upper SiN_x window. (b) Bottom-facing configuration utilized for TEM mode.

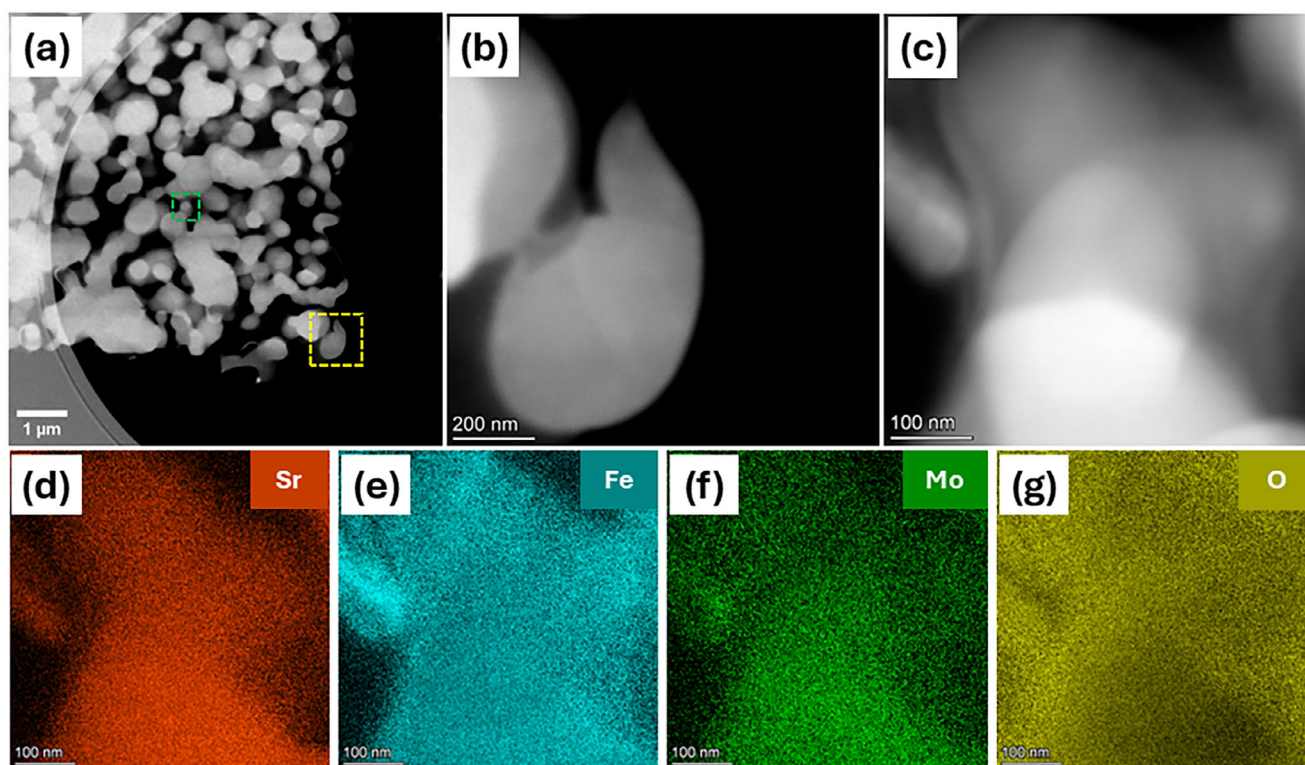


FIGURE 2 | Baseline nanoscale characterization of the as-prepared SFM bulk electrode lamella. (a) HAADF-STEM overview image showing SFM electrode of the SOC positioned over the SiN_x window. (b, c) Higher magnification HAADF-STEM images of the highlighted regions (yellow and green boxes in Figure 2a, respectively), showing the smooth, homogeneous surface characteristic of the pristine SFM. (d-g) EDS map of the corresponding region confirms homogeneous elemental distribution of Sr, Fe, Mo, and O.

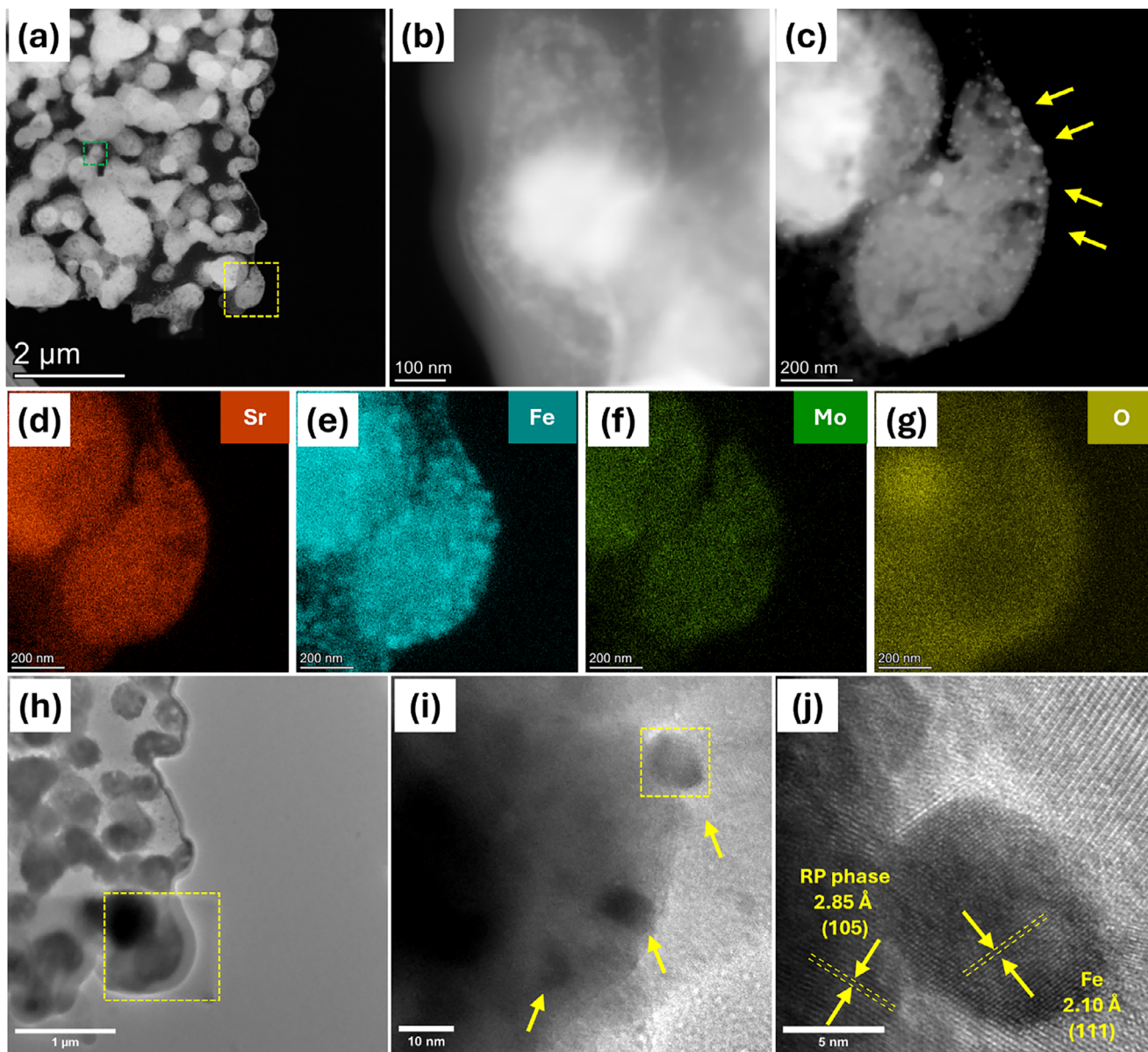


FIGURE 3 | Morphological and chemical evolution of SFM electrode after quasi-in situ off-beam reduction (4% H₂/Ar): (a) Overview image showing reduced SFM electrode. (b, c) High-magnification HAADF-STEM images of the highlighted regions (green and yellow boxes in Figure 3a, respectively) showing the high density of exsolved particles. (d–g) Corresponding EDS elemental maps of the region in (c), confirms the Fe exsolution. (h) BF-TEM overview image of reduced SFM electrode. (i) High-magnification BF-TEM resolving uniform distribution of exsolved particles. (j) HRTEM image resolving lattice parameters of Fe exsolution-(111) plane, and RP phase-(105) plane.

restructuring, characterized by densification and shrinkage of the electrode (Figure 3a). Higher-magnification images of the highlighted regions reveal a high-density of nanoscale surface features (Figure 3b,c). EDS mapping of the area Figure 3c confirms that while the bulk SFM matrix elements remain well-distributed, discrete, Fe-enriched nanoparticles have segregated at the surface edges, confirming successful reduction-driven exsolution [6, 22]. The nano-exsolutions span 5–45 nm in size, with an average diameter of 19 ± 6 nm (Figure S2). In contrast, the exsolutions in the reduced (100% H₂ for 10 h at 900°C) bulk SOC of the same composition range between 125–600 nm, with an average diameter of 280 ± 106 nm (Figure S3). The large spread in particle size in the bulk SOC most likely reflects the combined effects of the strongly reducing (100% H₂) atmosphere and

the longer holding time at high temperature. These conditions promote the nucleation and subsequent coarsening of exsolved particles. Furthermore, the availability of the bulk-electrode network provides abundant diffusion pathways and a larger cation reservoir, enabling sustained material transport for further particle growth. The effect of particle coarsening is also reflected in the exsolution density; the exsolution density per unit area is significantly higher in the reduced SOC lamella ($\sim 350/\mu\text{m}^2$) compared to the reduced bulk SOC ($\sim 3/\mu\text{m}^2$). Aspect-ratio (AR) analysis (Feret/MinFeret) shows that the lamella exsolutions are largely equiaxed (1.20 ± 0.21 ; median 1.15), whereas the bulk-cell exsolutions are more anisotropic (1.54 ± 0.57 ; median 1.39). The bulk-cell particles also display a broader distribution with a high-AR tail extending up to 4.8, indicating a greater

prevalence of elongated morphologies in the bulk electrode. The higher anisotropy observed in bulk-cell exsolutions likely reflects heterogeneous local reduction and extensive network transport conditions within the porous electrode and facet/boundary-guided growth, with additional contributions from particle coalescence during operation. Notably, when compared to our prior *in situ* reductions of isolated SFM powder particles, the bulk electrode lamella exhibits a markedly higher density of exsolved features [22]. The higher exsolution density in the lamella likely reflects the continuous, interconnected electrode network, which provides efficient bulk diffusion pathways for Fe transport to the surface.

A complementary bright-field (BF) TEM image of the reduced SFM electrode is shown in Figure 3h. High-magnification TEM image (Figure 3i), shows uniform distribution of exsolved nanoparticles on the reduced electrode surface. High-resolution TEM (HRTEM) confirms the crystallinity of these exsolutions; the measured lattice fringes ($d \approx 2.10 \text{ \AA}$) index to the Fe (111) plane, validating the formation of metallic Fe nanoparticles on the surface (Figure 3j). HRTEM analysis further reveals the formation of the layered tetragonal Ruddlesden-Popper (RP) $\text{Sr}_3\text{FeMoO}_7$ phase beneath the exsolution; the measured lattice fringes ($d \approx 2.85 \text{ \AA}$) indexed to (105) plane. This phase typically forms beneath exsolutions along grain facets of SFM double-perovskites, which aligns with our previous observations [6].

While formation of surface exsolutions upon reduction is clearly evident, understanding how this reduction-driven process reshapes the underlying electrode matrix requires deeper crystallographic insight. To assess these changes, we employed 4D-STEM mapping, acquiring a 2D diffraction pattern (DP) at each scan pixel [35, 38]. This rich 4D-STEM dataset enables both integrated differential phase-contrast (iDPC) imaging and radial Fourier analysis (RFA). While the RFA is used for rapid crystallographic orientation mapping, iDPC which is derived via the center-of-mass method of deflected beam, provides contrast approximately proportional to the projected electrostatic potential of the specimen. By capturing the beam deflection caused by local electrostatic fields, iDPC offers local phase information, high sensitivity to local structural gradients, and light elements compared to conventional HAADF-STEM [39–44].

For identical-location analysis, the same region of interest (RoI) was selected for both iDPC and RFA (Figure 4a). In the pre-reduction (as-prepared) state, the grains exhibit uniform Z-contrast in STEM, representative of the overall lamella quality prior to reduction (Figure S4). Correspondingly, the iDPC phase map of the as-prepared state is relatively smooth at the grain scale (Figure 4b). The iDPC magnitude contrast (Figure 4c) is dominated by grain-boundary outlines and bend contours rather than strong local potential gradients, a feature consistent with macroscopic lamella bending rather than intrinsic structural heterogeneity [45].

After reduction, the HAADF-STEM overview of the RoI shows exsolutions at different surfaces at the grain facets (Figure 4e), as shown by the highlighted regions. After reduction, the bend contours at grain boundaries are no longer observed, consistent with stress relaxation within the grains due to high-temperature annealing. It is observable from the iDPC phase and magnitude

vector maps that the regions exhibit smaller localized variations in comparison to the as-prepared SFM grains (Figure 4f,g), indicating a broader spread of deflection directions and stronger local phase gradients. Deflection was quantified from the vector CoM conversion of the 4D-STEM dataset, showing markedly higher beam-deflection magnitude in exsolution-rich regions, particularly near the grain edges, than in central grain regions. Bright regions around grain edges (most evident near the highlighted sites 1 and 2), indicate that strong deflection extends laterally along grain facets rather than being confined to discrete exsolution points (Figure 4g). This strong deflection along the grain facets is most likely due to the formation of an underlying layered tetragonal RP phase. RP layering can support distinct oxygen-defect configurations (vacancies and interstitial oxygen) and modified oxygen transport pathways, which may contribute to the strong local phase-gradient/deflection signatures measured near facet regions after reduction [46].

Similar high-contrast regions along grain facets, coinciding with higher exsolution density, are also observed in other reduced areas analyzed by iDPC (Figure S5). The weaker iDPC contrast and smoother phase in the central regions of grains are consistent with their greater local thickness, leading to increased multiple scattering events, which can partially mask exsolution-related signals. It needs to be stressed that iDPC contrast at this magnification is prone to thickness variation, dynamical scattering, and local bending. Thus, to eliminate the possibility that the generated iDPC contrast is merely an artifact of lower local thickness around the grain edges, and to confirm it is driven by the newly formed RP phase, it is critical to obtain local crystallographic information from these regions. To validate these crystallographic transformations, the same RoI was investigated using RFA. RFA reconstructs orientation maps by extracting the dominant angular distribution ($\sim 0\text{--}360^\circ$) from the pixelated DPs [33]. These angular distributions from the RoI were then used to generate the orientation (angle) maps (Figure 4d,h) before and after reduction, respectively. The orientation map of the as-prepared SFM lamella resolves distinct, coarse-grained orientations that closely follow the grain morphology observed in the corresponding HAADF-STEM image (Figure 4d). The reconstructed electron DPs from the highlighted regions (1–4) in the RoI exhibit orientations consistent with cubic $\text{Sr}(\text{Fe}_{0.8}\text{Mo}_{0.2})\text{O}_3$ (ICSD-191551) and tetragonal SrMoO_4 (ICSD-99089) phases (Figure S6). These are the same phases present in as-prepared SFM before reduction, as proven in our earlier investigation [22]. The RFA orientation color map of the same RoI exhibits drastic orientation changes and domain shrinkages within the same angular distribution range after reduction (Figure 4h). Such changes indicate that reduction-driven exsolution is accompanied by crystallographic rearrangement within the SFM grains rather than a purely surface-localized process. Comparison of the reconstructed electron DPs from the same highlighted regions (1–4) of the reduced SFM RoI, exhibit orientations consistent with reduction-driven lattice reorganization and partial phase evolution of SFM toward $\text{Sr}_2(\text{Fe}_{1.33}\text{Mo}_{0.66})\text{O}_{5.88}$ (ICSD-168704), and the tetragonal $\text{Sr}_3\text{FeMoO}_7$ (RP phase) (ICSD-156787) phases, both previously linked to Fe exsolution in reduced SFM (Figure S6) [21–23]. The formation of the RP phase in the highlighted regions 1 and 2 of the RoI, provides a plausible basis for the stronger deflection contrast observed around the grain boundaries in the iDPC color-map of the reduced SFM. Similar

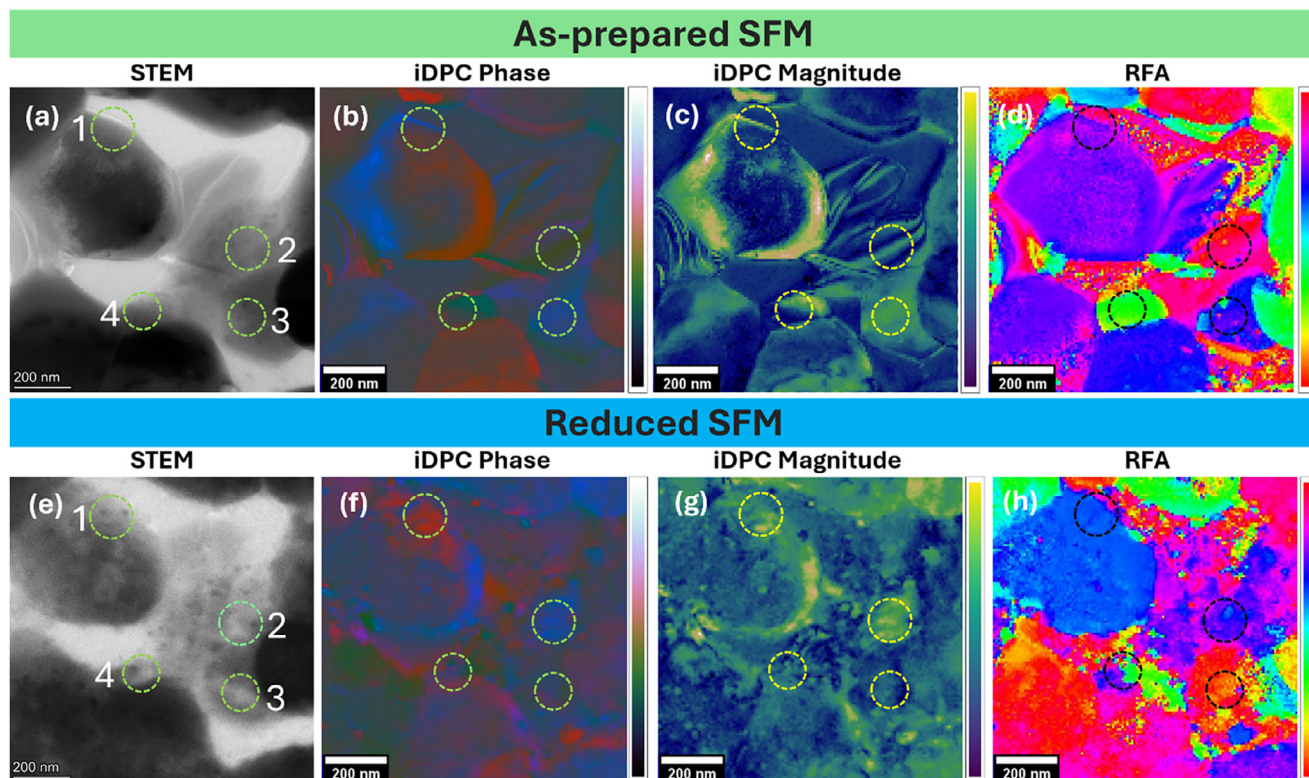


FIGURE 4 | 4D-STEM mapping of crystallographic and phase transformations in SFM in as-prepared and reduced states. (a, e) Identical-location HAADF-STEM images of the selected ROI in the (a) as-prepared, and (e) reduced states. (b, f) Corresponding iDPC phase maps showing transition from smooth, uniform grain contrast to a state with broader beam deflection and localized phase variations. (c, g) Corresponding iDPC magnitude vector maps revealing enhanced local phase gradients along grain facets after reduction. (d, h) Reconstructed orientation (angle) map reconstructed with RFA demonstrating that surface exsolution is accompanied by profound bulk domain shrinkage and crystallographic shifts within the identical spatial regions.

domain shrinkages and reorientations were observed at multiple locations within identical angular thresholds across the SFM electrode after reduction, further supporting this observation (Figure S5).

Similar to Co-doped SFM systems where reduction induces a coupled transformation into an RP phase plus metallic alloy nanoparticles, the facet-localized contrast and domain redistribution observed here are consistent with an RP-type near-surface transformation accompanying exsolution [46]. This observation indicates that the pronounced domain reorganization in the present study is dominated by the chemically driven redox processes (oxygen exchange, vacancy formation, and associated lattice reorganization) that accompany reduction.

Exsolution process is commonly described as a sequence of surface cation diffusion, reduction, nucleation, and growth; the present correlative 4D-STEM results extend this picture by capturing the accompanying crystallographic response of the host matrix in a bulk electrode geometry. By combining conventional STEM, TEM, and EDS with advanced 4D-STEM techniques (iDPC and RFA), this approach delivers a comprehensive, artifact-free view of how surface catalytic exsolution inherently couples to parent matrix reorganization in a realistic bulk geometry. Overall, the off-beam quasi-in situ workflow seamlessly correlates surface Fe-exsolutions with con-

current microstructural and crystallographic changes in the SFM electrode.

3 | Conclusion

In this study, we demonstrated a robust, off-beam quasi-in situ electron microscopy workflow to investigate the reduction-driven exsolution of $\text{Sr}_2\text{FeMoO}_{6-\delta}$ within a realistic solid oxide cell geometry. By extracting a pristine SFM lamella and performing identical-location 4D-STEM analysis before and after reduction in a MEMS reactor, we successfully isolated the intrinsic, thermodynamically driven material changes while eliminating the electron-beam-induced artifacts that frequently complicate in situ TEM data interpretations. Conventional STEM, TEM, and EDS confirmed that exsolution is highly active within the interconnected electrode network, yielding a denser array of exsolved Fe nanoparticles compared to isolated powder particles. Crucially, the application of advanced 4D-STEM techniques, specifically iDPC and RFA, revealed that surface exsolution is intimately linked to profound nanoscale reorganization within the bulk parent matrix. While iDPC visualized extended phase gradients indicative of Ruddlesden-Popper phase formation along the grain facets, RFA provided direct crystallographic evidence of concurrent domain shrinkage and phase evolution. Beyond validating exsolution trends in double-perovskites, this identical-location methodology establishes a direct, artifact-free

link between catalytic surface phenomena and bulk matrix structural responses. The datasets generated by this approach can be instrumental in identifying microstructural motifs that promote controlled exsolution, diagnosing degradation-induced phase transformations, and ultimately guiding the rational design of more stable, high-performance electrodes for next-generation SOCs. This method can also be further extended to other energy conversion systems such as battery electrodes, catalysts, redox oxides for deeper-dive into understanding their structural transformations in different environments under external stimuli of temperature and bias.

4 | Experimental section

4.1 | Material Synthesis and Cell Fabrication

Sr₂FeMoO_{6-δ} (SFM) powder was synthesized via a conventional solid-state route using precursor powders of MoO₃ (Alfa Aesar, 99%), SrCO₃ (Aldrich Chem, 99%), and Fe₂O₃ (Alfa Aesar, 99%) as previously established [22]. Commercial gadolinium-doped ceria (GDC, Ce_{0.8}Gd_{0.2}O_{1.9}, SOFCMAN, 99.5%) was used as a buffer layer between the electrodes and the 8 mol% yttria-stabilized zirconia (8YSZ) electrolyte. Each powder (SFM, and GDC) was mixed at a 50:50 wt.% ratio with a slurry solution of 3 wt.% ethyl cellulose (binder) in α -terpineol (dispersant). The slurries were homogenized using a planetary vacuum mixer (THINKY Mixer ARV-310, C3 Prozess und Analysentechnik GmbH, Germany) followed by roll milling. Single cells were fabricated by sequential screen printing (EKRA Screen Printing Technologies) on commercially available 8YSZ dense substrates (Kerafol, Germany; ~20 mm diameter, ~250 μ m thickness). First, GDC buffer layers (~5–7 μ m thick, ~18 mm diameter) were printed on both sides and sintered at 1375°C for 1 h in air to prevent the formation of insulating interfacial phases. Subsequently, symmetrical electrodes of SFM (~15–20 μ m thick, ~10 mm diameter) were printed on both sides and sintered at 1150°C for 2 h in air, yielding symmetrical SFM/GDC/8YSZ/GDC/SFM cells with homogeneous microstructures. The fabricated cells were fractured, embedded in epoxy, and polished to expose flat cross-sectional surfaces suitable for PFIB lamella preparation.

4.2 | Lamella Preparation

Lamella preparation was conducted on Tescan AmberX Plasma FIB-SEM. SE and BSE images were acquired at 5 kV and 300 pA, and EDS maps at 20 kV and 1 nA. PFIB parameters for lamella preparation and MEMS-transfer are provided within supplementary information.

4.3 | Quasi-In Situ Reduction

Reduction was performed on the SOC lamella mounted on DENSolutions Climate gas-heating MEMS chip in a Climate Infinity holder. Off-beam reduction used 4% H₂/Ar at 1 bar and 1 mL/min flow rate, for 30 min at 800°C. Prior to reduction, the assembled MEMS chamber within the holder was purged with Ar (5 mL/min) at 300°C for 15 min to minimize contamination.

4.4 | STEM & TEM Characterization

Bright field (BF), and high-angle annular dark field (HAADF) STEM images were acquired on a Cs probe-corrected FEI Titan G2 80–200 ChemiSTEM operated at 200 kV. EDS maps were collected using the Super-X EDX detector (ChemiSTEM). BF-TEM imaging was performed on an FEI Titan 80–300 kV TEM. 4D-STEM data was collected using a pixelated 4D STEM detector (EMPAD), and the data analysis was performed by considering a virtual ring detector via python based LibeTEM packages for RFA, and iDPC methods [47].

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Conflicts of Interest

The authors declare no conflicts of interest.

Data Availability Statement

The data that support the findings of this study are available from the corresponding author upon reasonable request.

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Supporting Information

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